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Anisotropic leaky-like perturbation with subwavelength gratings enables zero crosstalk

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Abstract

Electromagnetic coupling via an evanescent field or radiative wave is a primary characteristic of light, allowing optical signal/power transfer in a photonic circuit but limiting integration density. A leaky mode, which combines both evanescent field and radiative wave, causes stronger coupling and is thus considered not ideal for dense integration. Here we show that a leaky oscillation with anisotropic perturbation rather can achieve completely zero crosstalk realized by subwavelength grating (SWG) metamaterials. The oscillating fields in the SWGs enable coupling coefficients in each direction to counteract each other, resulting in completely zero crosstalk. We experimentally demonstrate such an extraordinarily low coupling between closely spaced identical leaky SWG waveguides, suppressing the crosstalk by ≈ 40 dB compared to conventional strip waveguides, corresponding to ≈ 100 times longer coupling length. This leaky-SWG suppresses the crosstalk of transverse-magnetic (TM) mode, which is challenging due to its low confinement, and marks a novel approach in electromagnetic coupling applicable to other spectral regimes and generic devices.

Introduction

Advances in photonic research have led to the integration of various optical components into chip-scale photonic integrated circuits (PICs) for a wide range of applications, including optical computing¹, quantum communication^{2,3}, light detection and ranging (LIDAR)^{4–6}, microcomb and optical metrology^{7–9}, and biochemical sensing^{10,11}. The increasing complexity of PICs requires more and more components in a chip, yet chip scalability is limited by the crosstalk prevailing in any optical system. Even a well-confined guided mode (Fig. 1a) exhibits exponentially decaying evanescent fields in the cladding, causing optical coupling between adjacent devices. While this evanescent coupling facilitates some components like couplers and splitters^{12–14}, it is still the primary origin of crosstalk, limiting the chip integration

density. Approaches based on inverse design¹⁵, phase-mismatching^{16,17}, adiabatic elimination¹⁸, and skin-depth engineering^{19,20} have been proposed to reduce the crosstalk, yet they are mostly for transverse electric (TE) mode with additional limiting factors.

Recently, anisotropic metamaterials formed by sub-wavelength grating (SWG) nano-patterns have been utilized to design various PIC components, greatly expanding the design space^{21–25}. By making the grating period smaller than the wavelength, SWGs behave as a homogeneous anisotropic medium, and their effective index can be engineered with their geometric parameters. The large design flexibility of SWGs has been used in advancing various photonic components such as optical delay lines²⁶, fiber-chip couplers^{27–29}, biosensors^{30,31}, Bragg filters^{32,33}, and polarization controlling devices^{34–37}. An extreme skin-depth (eskid) waveguide scheme that utilizes SWGs to reduce the skin depth of evanescent fields was recently proposed, significantly suppressing the crosstalk for dense chip integration^{19,20}. However, such a skin-depth suppression approach works only with TE polarization, whose dominant electric field is parallel to the chip surface. In

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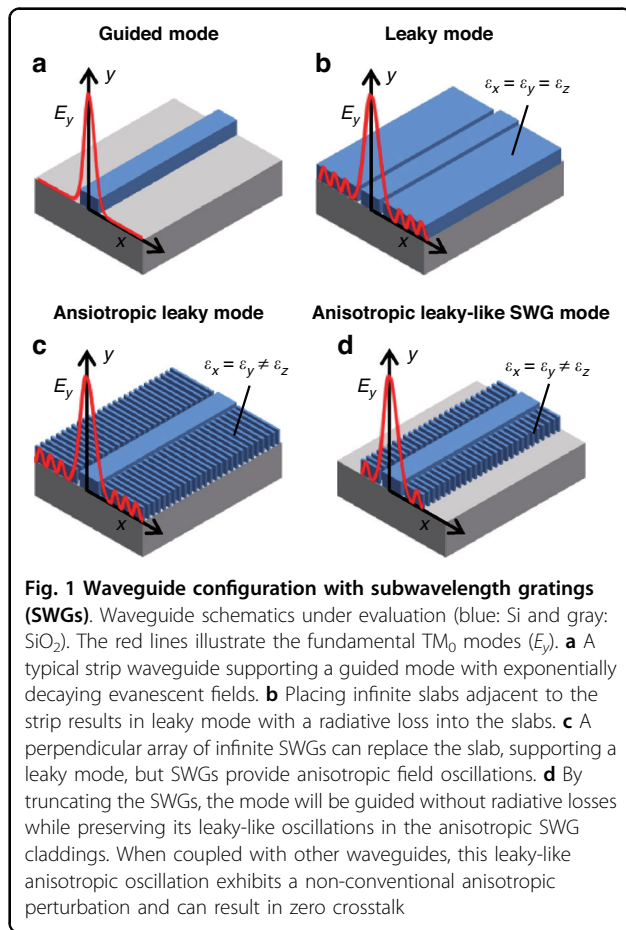
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various PICs, transverse-magnetic (TM) mode, whose dominant electric field is vertical to the chip surface, doubles chip capacity and plays important roles in biochemical and gas sensing with its extended fields in the vertical direction^{11,38,39}. Despite its significance, TM is difficult to confine due to a low height-to-width aspect ratio (for easy etching) and exhibits larger crosstalk than TE. The eskid waveguide also causes a stronger coupling for TM mode with increased skin depth⁴⁰, and this large TM crosstalk issue still remains a challenge, impeding progress toward high-density chip integration.

As illustrated in Fig. 1b, a leaky mode can be formed by coupling a guided waveguide mode to the continuum of radiation modes in the surrounding infinite clad media^{12,41,42}. While the mode is propagating, the spread of these radiations enables coupling with other devices even when they are far apart. This radiative coupling provides a major advantage in directional couplers^{43–45} and polarization splitters⁴⁶, as the coupling length remains short with increasing separation distance. But it also proves to counteract when it comes to unwanted waveguide crosstalk, as the cladding radiation significantly enhances the coupling strength between waveguides. Leaky modes,

therefore, are not considered ideal for dense integration. However, by orienting the SWGs perpendicular to the propagation direction (Fig. 1c), we can form a leaky mode for TM polarization and achieve zero crosstalk. This counter-intuitive approach relies on the anisotropic nature of SWGs, for which each field component (i.e., E_x , E_y , and E_z) in the radiative waves will be weighted differently than the isotropic cladding case (Fig. 1b). Each component can be engineered anisotropically to cancel out the overall coupling strength by changing the homogenized optical indices of SWG metamaterials. For the practical use of anisotropic leaky mode, the SWG lengths can be truncated finite as in Fig. 1d, forming a leaky-like mode. Despite the reduced cladding width, this guided mode still exhibits anisotropically oscillating fields in the cladding. These oscillating patterns are the primary characteristic of a leaky mode, and the field perturbations can be engineered depending on the finite width of SWGs that corresponds to the spacing between the two identical waveguides. The finite SWG width also removes the radiative losses, which is due to the leakage through the cladding.

In this work, we show that an anisotropic leaky-like oscillation realized by SWG metamaterials (as in Fig. 1d) can cancel crosstalk completely, i.e., zero crosstalk. The leaky-like oscillation and zero crosstalk are realized with TM polarization, the bottleneck for chip integration due to its lower confinement. Starting by looking into the modal properties of leaky SWG modes, we apply coupled-mode analysis to reveal the unique dielectric perturbation of anisotropic leaky-like mode, finding zero crosstalk between closely spaced identical SWG waveguides. Then, using Floquet boundary simulations, we design practically implementable SWG waveguides on a standard silicon-on-insulator (SOI) platform and experimentally demonstrate near-zero crosstalk, drastically increasing the coupling length of TM mode by more than two orders of magnitudes.

Results

Anisotropic leaky-like oscillation with SWGs

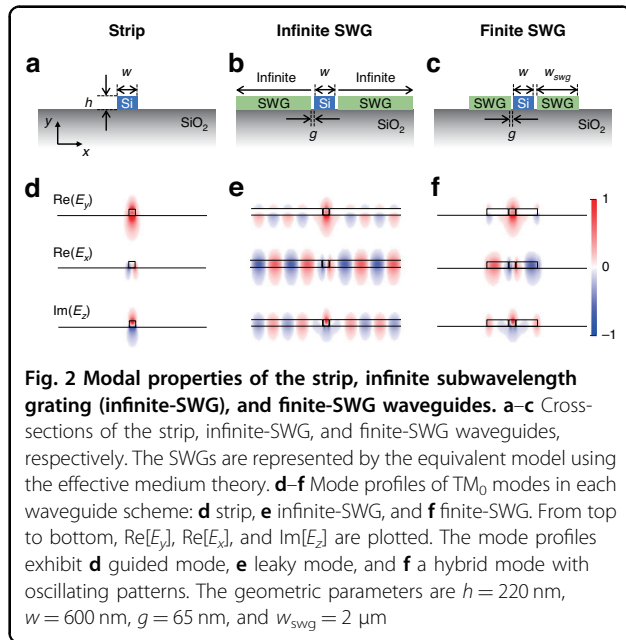
To see the modal properties, we first simulated the fundamental TM (TM₀) mode of a single waveguide and plotted their field components in each direction. Figure 2a–c shows the cross-sections of the strip, infinite-SWG, and finite-SWG waveguides, respectively. In order to model the anisotropic SWGs, we used the effective medium theory (EMT) with the permittivities $\epsilon_x = \epsilon_y = \epsilon_{||}$ and $\epsilon_z = \epsilon_{\perp}$ given by⁴⁷,

$$\epsilon_{||} = \rho\epsilon_{\text{Si}} + (1 - \rho)\epsilon_{\text{air}} \quad (1a)$$

$$\epsilon_{\perp} = \frac{\epsilon_{\text{Si}}\epsilon_{\text{air}}}{\rho\epsilon_{\text{air}} + (1 - \rho)\epsilon_{\text{Si}}} \quad (1b)$$

where ρ is the filling fraction of silicon (Si) in the cladding, and ϵ_{Si} and ϵ_{air} are the permittivities of Si and air,





respectively. The electric field profiles of each waveguide scheme are shown in Fig. 2d–f, from top to bottom, plotting the normalized $Re(E_y)$, $Re(E_x)$, and $Im(E_z)$ (see Supplementary Information Fig. S1 for magnetic field components). The strip waveguide (Fig. 2a, d) supports a well-confined/guided TM_0 mode, exhibiting a dominant E_y field. On the other hand, the infinite-SWG waveguide (Fig. 2b, e) shows a leaky mode with laterally radiating waves. Now the E_x and E_z are not negligible due to radiative waves, while E_y is still dominant in the core. Truncating the SWG cladding layers to a finite width w_{swg} (Fig. 2c) makes the mode confined, but the oscillating fields in the SWG claddings remain the same exhibiting leaky-like field patterns (Fig. 2f). These oscillating waves in the SWGs can be controlled by changing the w_{swg} (see Supplementary Information Fig. S2), introducing non-trivial dielectric perturbations once coupled with other waveguides. The gap g is introduced between the Si core and SWG claddings to minimize scattering losses from a sharp corner in the experiment, but the modal properties show similar trends even without the gap (see Supplementary Information Fig. S3).

Zero crosstalk in leaky-like SWG TM modes

To examine the coupling effect, we simulated the coupled modes of the two identical waveguides and compared their coupling lengths. The cross-sections and geometric parameters of the coupled strip and SWG waveguides are depicted in Fig. 3a, b, respectively. The EMT models in Eq. (1) represent the finite, perpendicular SWG claddings in Fig. 3b. The coupling length L_c is used to quantify the

crosstalk, which defines the minimal length over which optical power is maximally transferred from one waveguide to the other⁴⁸. The coupling length is a critical metric for comparing the degree of waveguides crosstalk (i.e., ratio of power exchange), as the degree of crosstalk varies per waveguide length. The simulated effective indices of the coupled TM_0 symmetric (red, n_s) and anti-symmetric (blue, n_a) modes are plotted in Fig. 3c (strip) and Fig. 3d (SWG) as a function of SWG width w_{swg} , with their corresponding coupling lengths shown in Fig. 3e, f, respectively. The coupling lengths are normalized by the free-space wavelength $\lambda_0 = 1550$ nm, and are evaluated using^{48,49},

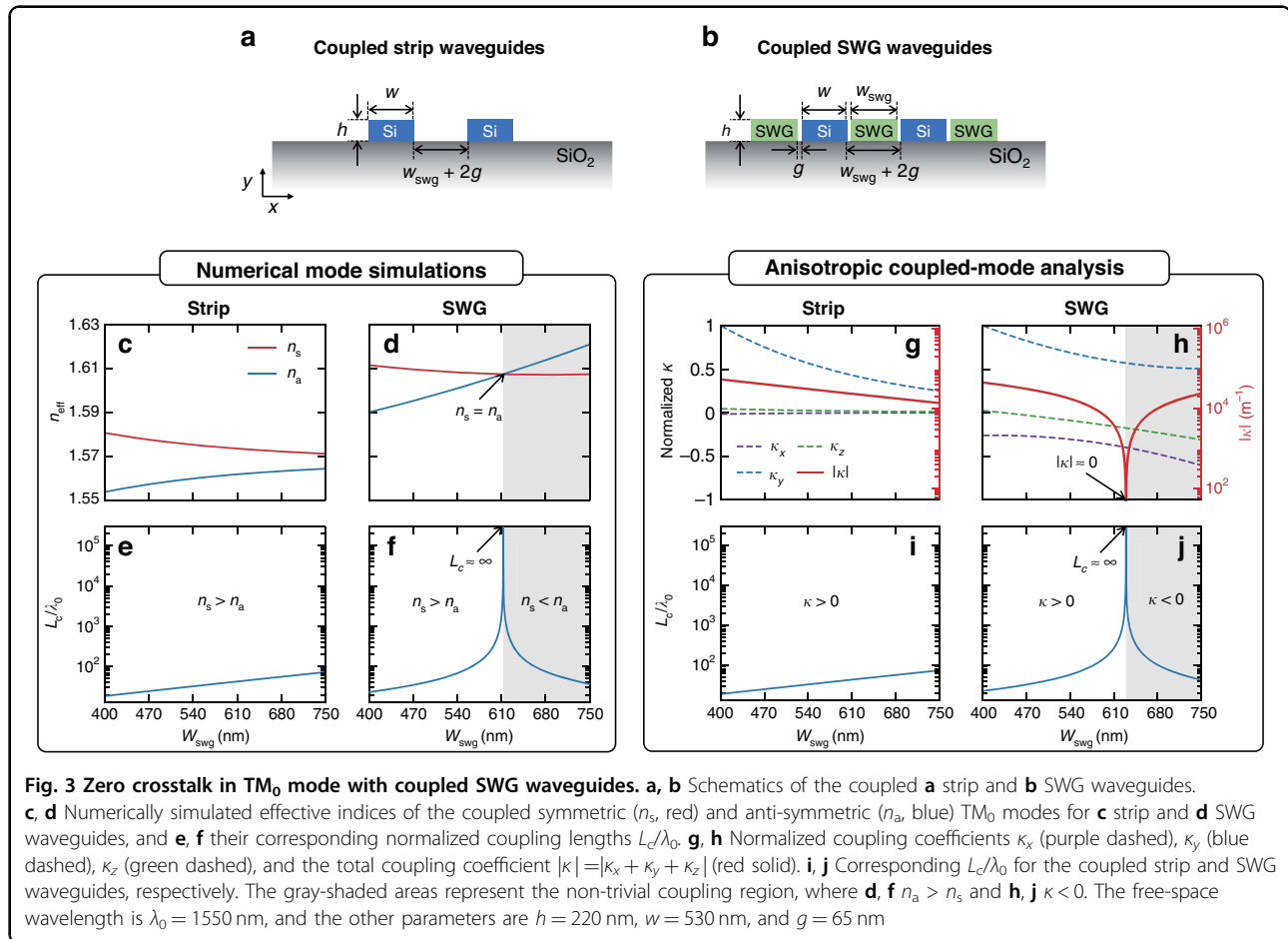
$$\frac{L_c}{\lambda_0} = \frac{1}{2\Delta n} = \frac{1}{2|n_s - n_a|} \quad (2)$$

where $\Delta n = |n_s - n_a|$ is the index difference between the symmetric and anti-symmetric modes. With the coupled strip waveguides (Fig. 3a), a typical trend where n_s is larger than n_a and they get closer as w_{swg} increases are seen (Fig. 3c), having limited L_c/λ_0 less than 100 waves (Fig. 3e). This very short coupling length is due to less confinement from TM_0 mode for the given separation distances, making TM_0 mode difficult for dense integration. For comparison, a typical L_c/λ_0 of fundamental TE mode for the same separation distance ranges approximately between 10^3 and 10^4 waves (see Supplementary Information Fig. S4). However, the coupled SWG waveguides (Fig. 3b) show a non-trivial coupling region where $n_s < n_a$ (gray-shaded region, Fig. 3d). Moreover, at the transition point from the trivial coupling ($n_s > n_a$) to the non-trivial one ($n_s < n_a$), the index difference Δn becomes zero ($n_s = n_a$), which indicates infinitely long coupling length $L_c = \infty$ (from Eq. 2). This infinitely long coupling length is directly seen in Fig. 3f. It is worth noting that the TM_0 of SWG waveguides supports leaky-like radiative waves in the cladding, which is supposed to exhibit larger crosstalk (thus, less coupling length) unless there is such a non-trivial coupling.

Anisotropic dielectric perturbation with SWGs

To further understand the role of leaky-like SWG mode in achieving zero crosstalk, we investigate each coupling scheme using the coupled-mode analysis^{48,49}. The coupling coefficients κ_x , κ_y , and κ_z from each field component (E_x , E_y , and E_z) are calculated separately and then summed together to get the total coupling coefficient $|\kappa| = |\kappa_x + \kappa_y + \kappa_z|$ (see “Methods”). Figure 3g, h show the calculated coupling coefficients of the coupled strip and SWG waveguides, respectively, as a function of w_{swg} : normalized κ_x , κ_y , and κ_z (dashed lines, left axis) and $|\kappa|$ (solid red line,





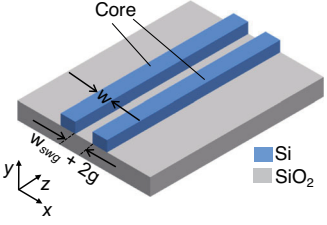
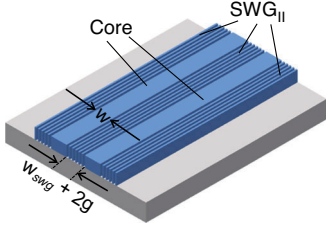
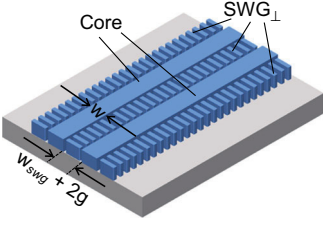
right axis). The coupling length is calculated using⁴⁹,

$$L_c = \frac{\pi}{2|\kappa|} \quad (3)$$

and the corresponding normalized L_c/λ_0 of the coupled strip and SWG waveguides are plotted in Fig. 3i, j, respectively. For a guided TM_0 mode (Fig. 3a, g), κ_y is dominant with a high E_y field, while the other components κ_x and κ_z are negligible. As w_{swg} enlarges, all the coupling coefficients decrease due to the exponentially decaying evanescent fields in the cladding, reducing the dielectric perturbation strength between the coupled waveguides. On the other hand, in the coupled SWG waveguides (Fig. 3b, h), the κ_x and κ_z show a non-conventional trend, i.e., their magnitudes increase with w_{swg} . The oscillating fields in the leaky SWG attributed to this non-conventional dielectric perturbation, which allows the negative κ_x and κ_z to counteract the positive κ_y component, leading to the complete cancellation of the total coupling coefficient $|\kappa| = 0$ at a certain point (Fig. 3h). The corresponding L_c approaches infinity at this $|\kappa| = 0$ point, as seen in Fig. 3j. The results closely match with the full numerical

simulations in Fig. 3f. A small difference between Fig. 3f and Fig. 3j is noted, which is likely due to the strong perturbation of the leaky-like SWG mode, which is not adequately accounted for in the coupled-mode analysis. It is important to note that the coupled-mode analysis is an approximation that assumes small perturbations, such as exponentially decaying evanescent coupling in the case of guided modes. Despite this deviation, the results in Fig. 3h provide valuable insight into the zero crosstalk behavior of the leaky-like SWG mode. The shaded regions in Fig. 3h, j show the non-trivial coupling regimes where $\kappa < 0$, which corresponds to the $n_s < n_a$ region in Fig. 3d, f. Note that this exceptional coupling achieving zero crosstalk is due to the anisotropic dielectric perturbations of the leaky-like oscillations realized by SWGs, where $\Delta\epsilon_x = \Delta\epsilon_y > \Delta\epsilon_z$. With a conventional isotropic ($\Delta\epsilon_x = \Delta\epsilon_y = \Delta\epsilon_z$) leaky mode, such a complete zero crosstalk is impossible to achieve as $|\kappa|$ is always greater than zero. In the case of a conventional well-confined guided mode, including an eskid waveguide for TE mode^{19,20}, the coupling coefficient components κ_x , κ_y , and κ_z typically decrease as the separation distance increases due to the exponentially decaying evanescent field. However, as shown in Fig. 3h,

Table 1 Comparison table of dielectric perturbations and coupling mechanisms between strip, eskid, and leaky SWG waveguide schemes

Structure	Strip waveguides	Eskid waveguides ^{19,20}	Leaky SWG waveguides (this work)
Schematics			
Mode	Guided mode	Guided eskid mode	Leaky-like SWG mode
Coupling mechanisms	Evanescent coupling	Extreme skin-depth + anisotropic evanescent coupling	Anisotropic leaky-like oscillative coupling
Dielectric perturbations	$\Delta\epsilon_x = \Delta\epsilon_y = \Delta\epsilon_z$	$\Delta\epsilon_x < \Delta\epsilon_y = \Delta\epsilon_z$	$\Delta\epsilon_x = \Delta\epsilon_y > \Delta\epsilon_z$
L_c/λ_0 (TE) ^a	$\approx 10^3 - 10^4$	$\approx 10^4 - \infty$	$\approx 10^2 - 500$
L_c/λ_0 (TM) ^a	$\approx 20 - 10^2$	$\approx 10^1 - 30$	$\approx 10 - \infty$

^aThese data are for a range of $w_{\text{swg}} = 400\text{--}750$ nm (see Supplementary Fig. S7 for detailed data)

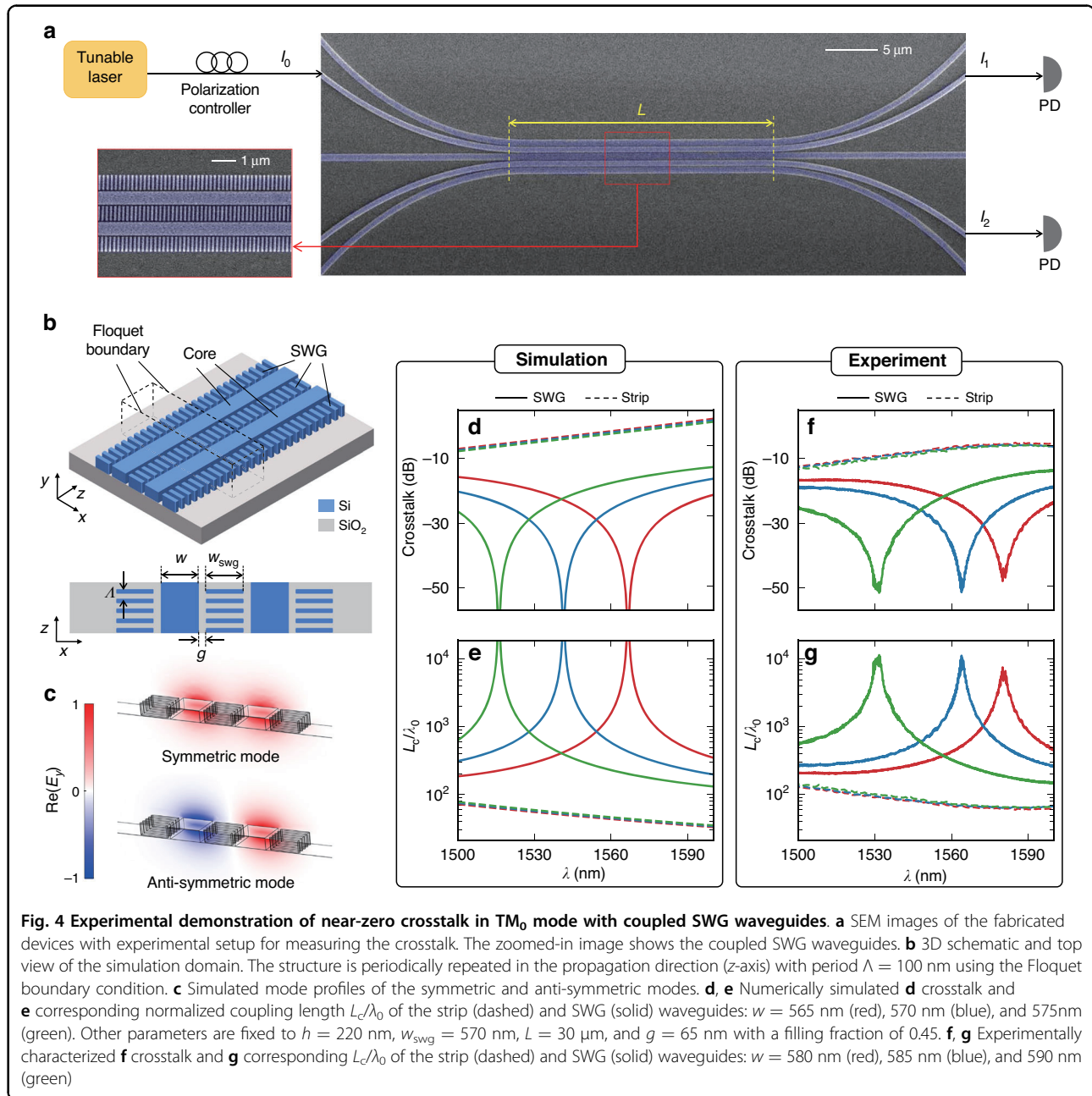
our leaky-like SWG mode exhibits an unconventional trend in which κ_x and κ_z increase even as the separation distance increases (here, w_{swg}). The anisotropic perturbation realized by this oscillative leaky trend is the key to achieving zero crosstalk in TM mode. This stands in contrast to the highly confined eskid approach for TE mode^{19,20}, as summarized in Table 1. These coupling singularities via anisotropic dielectric perturbations could also vary with different core widths w , as shown in Supplementary Information Fig. S5. Furthermore, this anisotropic perturbation approach can be easily extended to multiple waveguides array (see Supplementary Information Fig. S6) and also be optimized to reduce the width of the SWGs, potentially pushing the limits of the separation distance between the two waveguides.

Experimental results

In order to verify our findings, we fabricated the coupled SWG waveguides and experimentally characterized their crosstalks. We fabricated our SWG devices on a 220 nm-thick SOI wafer using a standard electron beam nanolithography process (see “Methods”). Figure 4a shows the scanning electron microscope (SEM) images of the fabricated devices with a schematic experimental setup for measuring the crosstalk. As the ideal EMT model and practical SWGs would differ in effective indices, we used Floquet modal simulations to optimize structures with realistic parameters (see “Methods”). Figure 4b shows schematics of the simulation domains (top: perspective-view and bottom: top-view), and Fig. 4c represents the

mode profiles (E_y) of the coupled TM₀ symmetric (top) and anti-symmetric (bottom) modes. Figure 4d shows the simulated crosstalk spectra of the coupled SWG waveguides (solid lines) for different core widths $w = 565$ nm (red), 570 nm (blue), and 575 nm (green). For comparison, the crosstalks of the coupled strip waveguides without SWGs are also plotted (dashed lines). As expected from previous modal simulations using an ideal EMT, complete zero crosstalks (dips) are seen, resulting in infinitely long coupling lengths as in Fig. 4e. The zero crosstalk phenomenon is highly dependent on the anisotropic properties of SWGs, which can be manipulated by varying the filling fraction of the grating structures. This allows for the engineering of the zero crosstalk wavelength, as shown in Supplementary Information Fig. S8. For the experimental characterization, we sent light I_0 through one of the coupled waveguides and measured output power ratios I_2/I_1 , which defines the crosstalk. Grating couplers are used for interfacing the chip and fibers. Figure 4f, g show the experimentally characterized crosstalk and L_c/λ_0 corresponding to the results in Fig. 4d, e, respectively. The crosstalk of coupled SWG waveguides is drastically suppressed down to as low as -50 dB (Fig. 4f), approximately 40 dB lower than coupled strip waveguides. In terms of the coupling length (Fig. 4g), the maximum L_c/λ_0 of the SWG waveguides is $\approx 10^4$ waves, which is about two orders of magnitudes longer than the strip case. Unlike the ideal SWG simulations, there is a practical limit in measuring the minimum crosstalk due to background noise in the chip, either from sidewall roughness





scattering or cross-coupling at the strip to SWG transition. Still, to our knowledge, the TM_0 crosstalk suppression shown here is the lowest recorded, with a coupling length encompassing $\sim 10^4$ waves. To explicitly show the effectiveness of our approach, we summarize key performance factors in Table 2 and compare them with other TM crosstalk suppression approaches^{15,18,50–52}.

It is worth noting that the zero crosstalk condition is sensitive to geometric parameters, and therefore the zero crosstalk bandwidth is limited. There is a trade-off between bandwidth and L_c/λ_0 ; quantitatively, the bandwidth for $L_c/\lambda_0 > 1000$ waves is $\approx 20.1 \pm 3.0$ nm

(see Supplementary Information Fig. S9). This bandwidth can be broadened by tailoring the modal dispersions or by smoothly tapering the widths of SWGs or core, but this may come at the cost of reduced peak crosstalk suppression.

Discussion

In summary, we uncovered that anisotropic leaky-like oscillations can achieve complete zero crosstalk by engineering dielectric perturbations anisotropically to cancel out the couplings from each field component. We realized such anisotropic leaky-like oscillations using the perpendicularly



Table 2 Coupling length L_c comparison of TM mode with different waveguide configurations

Waveguide configuration	Polarization	$H \times W$ (nm $\times$ nm)	Separation (μm)	Coupling length, L_c (mm)	Normalized coupling length, L_c/λ_0	Optical loss (dB/cm)
Strip ^{50–52}	TM	220 $\times$ 590	0.80–1.20	0.010–2.75	6.45–1740	Low (0.50–2.0)
	TE	220 $\times$ 450				
Cloaking ¹⁵	TM	300 $\times$ 300	0.80	0.72	465	High (>300)
Adiabatic elimination ¹⁸	TM	340 $\times$ 220	0.94	5.8 ^a	4400 ^a	N/A
Leaky SWG (this work)	TM	220 $\times$ 590	1.19	17.51	11,300	Low (≈ 3.00) ^{b,19,23–26}

^aThe wavelength of ref. ¹⁸ is at 1310 nm, while all the other wavelengths are at 1550 nm

^bThe detailed loss value varies per design

arrayed SWGs and optimized via Floquet numerical simulations. We experimentally demonstrated the extreme suppression of TM crosstalk on an SOI platform, achieving ≈ 40 dB crosstalk suppression and two orders of magnitude longer coupling lengths than typical strip waveguides. Our work directly provides a practical and easily applicable waveguide platform for overcoming the integration density limit of TM mode and should be pivotal for advancing PIC technologies in applications like on-chip biochemical/gas sensing and polarization-encoded quantum/signal processing. Furthermore, our proposed method of using anisotropic SWGs to achieve zero crosstalk reveals a novel coupling mechanism with a leaky mode, easily extendable to other integrated photonics platforms and covering visible to mid-infrared and terahertz wavelengths beyond the telecommunication band.

Methods

Coupled-mode analysis

The coupling coefficient components κ_i of the coupled strip and SWG waveguides were calculated using the coupled-mode theory^{48,49},

$$\kappa_i = \frac{\omega \epsilon_0}{4} \iint \Delta \epsilon_i(x, y) E_{1i}(x, y) E_{2i}^*(x, y) dx dy \quad (4)$$

where $i = x, y$, and z denotes the coupling coefficient from each field component. By isolating the waveguides at each side (without coupling), the unperturbed normalized electric fields of the TM_0 modes are obtained as E_{1i} and E_{2i} . $\Delta \epsilon_i$ is the dielectric perturbation imposed by the presence of the individual waveguides on each other. The total coupling coefficient $|\kappa|$ between the coupled waveguides was obtained by adding the individual components together,

$$|\kappa| = |\kappa_x + \kappa_y + \kappa_z| \quad (5)$$

and the corresponding coupling length is given by $L_c = \pi/(2|\kappa|)$. The analysis was carried out at a free-space wavelength of $\lambda_0 = 1550$ nm.

Numerical simulations

For the conceptual studies conducted in Figs. 2 and 3, we used the EMT to account for the anisotropic properties of SWGs and ran 2D modal simulations. However, since there is a mismatch between the EMT and real SWGs, we used the Floquet modal approach for designing real experimental devices. The method of the Floquet approach is described below.

Floquet modal simulations

We used a commercially available finite element method simulator (COMSOL Multiphysics) to model and simulate the practically implementable SWG waveguides. We simulated the eigenfrequencies of the given structure by alternating Si layers perpendicular to the waveguide propagation direction (z -axis) with Floquet boundary conditions. The structure is spatially repeated with period $\Lambda = 100$ nm by imposing the Floquet boundary conditions at each end of the simulation domain (see Fig. 4b). For setting the Floquet periodicity, we defined the wave vector as $k_z = \frac{2\pi}{\Lambda} n_{\text{eff}}$, where n_{eff} is the effective index of the TM_0 mode at a particular wavelength λ . The simulations were carried out for different core widths indicated by $w = 565$ nm (red), 570 nm (blue), and 575 nm (green) in Fig. 4d, e. The Floquet simulations can reasonably estimate the geometric parameters required to achieve complete zero crosstalk. These optimized parameters are fixed at height $h = 220$ nm, SWG width $w_{\text{swg}} = 570$ nm, and gap $g = 65$ nm with a filling fraction of 0.45. Edges of SWGs are also rounded, considering the fabricated devices shown in the SEM images.

Device fabrication

The photonic chips were fabricated on an SOI wafer with 220 nm thick Si and 2 μm SiO_2 substrate, using the JEOL JBX 6300-fs electron beam lithography (EBL) system. The operating conditions were 100 KeV energy, 400 pA beam current, and 500 $\mu\text{m} \times 500 \mu\text{m}$ field exposure. A solvent rinse was done initially, followed by O_2 plasma



treatment for 5 min. Hydrogen silsesquioxane resists (HSQ, Dow-Corning XR-1541-006) was spin-coated at 4000 rpm and pre-exposure baked on a 90° hotplate for 5 min. The exposure dose used was 2800 $\mu\text{C}/\text{cm}^2$. During shot shape writing, the machine grid shape placements, the beam stepping grid, and the spacing between dwell points were 1 nm, 4 nm, and 4 nm, respectively. The resist was developed in 25% tetramethylammonium hydroxide (TMAH) heated to 80° and placed into the solution for 30 s, and then rinsed in flowing deionized water for 2 min and isopropanol for 10 s. Nitrogen was blown in for air drying. The die was placed in an O₂ plasma asher at 100 W for 15 s with 10 sccm O₂ flowing into the system. The unexposed top Si device layer was etched using Trion Minilock III ICP-RIE etcher at 50 W RF power and 6.2 mTorr pressure with Cl₂ and O₂ gas flowing into the chamber at 50 sccm and 1.4 sccm, respectively. An active cooling system maintained the stage temperature stably at 10 °C during the entire etching process.

Crosstalk characterization

The crosstalk of the strip and SWG coupled waveguides was characterized by measuring their respective output power ratio. Light from a tunable laser source with optical power I_0 was coupled to the input port using grating couplers (see Fig. 4a). A Keysight Tunable Laser 81608A was used as a source, and an angle-polished (8°) fiber array was used to couple light into the grating coupler. A polarization controller was used to ensure the input light polarization was TM. By simultaneously measuring the output powers I_1 and I_2 at the through and coupled ports, the crosstalk was calculated as the ratio I_2/I_1 . A Keysight N7744A optical power meter was used to detect the output powers. The coupling length L_c was extracted from the relation⁴⁸,

$$\frac{I_2}{I_1} = \tan^2\left(\frac{\pi L}{2L_c}\right) \quad (6)$$

where $L = 30 \mu\text{m}$ is the length of the coupled waveguides. The measurements were taken for core widths $w = 580 \text{ nm}$ (red), 585 nm (blue), and 590 nm (green) (see Fig. 4f, g).

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Author contributions

S.K. developed the idea and supervised the project. M.F.K. and M.B.M. modeled the structures and performed the numerical simulations with the support of S.K. I.A. fabricated the Si devices. N.J. and S.Z.A. experimentally characterized the devices. S.K. and M.F.K. prepared the figures and wrote the manuscript.

Data availability

The data that support the findings of this study are available from the corresponding author upon reasonable request.

Conflict of interest

The authors declare no competing interests.

Supplementary information The online version contains supplementary material available at <https://doi.org/10.1038/s41377-023-01184-5>.

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